

SPECIFICATION

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SPEC. NO.:	PS-922	203-XXXXX-XXX	REVISION:	0
PRODUCT N	AME:	2.5mm WTB WAFER	CONN.	
PRODUCT N	O:	92203 SERIES		

PREPARED:	CHECKED:	APPROVED:		
CHENBO	CARL	JASON		
DATE: 12/10/16	DATE: 12/10/16	DATE: 12/10/16		

evision History	E: 2.	5mm WTB WAF	ER CONN.				
Rev. ECN # Revision Description Prepared Date	ASE DATE: 2012/10/16 REVISION: O ECN No: ECN-1210170 PAGE: 3 OF						
Rev. ECN # Revision Description Prepared Date	Revision History						
O ECN-1210170 NEW SPEC CHENBO 12/10/16	Rev.	ECN#	R	Revision De	escription	Prepared	
	0	ECN-1210170	NEW SPEC			CHENBO	12/10/16
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TITLE: 2.5mm WTB WAFER CONN.

2 SCOPE

This specification covers performance, tests and quality requirements for 2.5mm WTB Wafer Conn. These connectors are used in cars.

3 APPLICABLE DOCUMENTS

EIA-364: ELECTRONICS INDUSTRIES ASSOCIATION

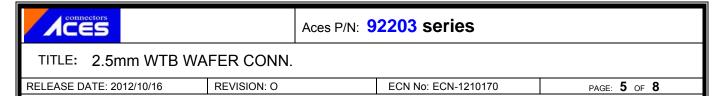
4 REQUIREMENTS

- 4.1 Design and Construction
 - 4.1.1 Product shall be of design, construction and physical dimensions specified on applicable product drawing.
 - 4.1.2 All materials conform to R.o.H.S. and the standard depends on TQ-WI-140101.
- 4.2 Materials and Finish
 - 4.2.1 Contact: High performance copper alloy(Brass)

Finish: (a) Contact Area: Refer to the drawing

(b) Under plate: Refer to the drawing(c) Solder area: Refer to the drawing

- 4.2.2 Housing: Thermoplastic High Temp., UL94V-0
- 4.3 Ratings
 - 4.3.2 Voltage: 13 Volts DC (per pin)
 - 4.3.3 Current: 3 Amperes (per pin)
 - 4.3.3 Operating Temperature : -40°C to +120°C



5 Performance

5.1. Test Requirements and Procedures Summary

Item	Requirement	Standard		
	Product shall meet requirements	Visual, dimensional and functional per		
Examination of Product	of applicable product drawing and specification.	applicable quality inspection plan.		
	ELECTRICAL	<u>-</u>		
Item	Requirement	Standard		
Low Level Contact Resistance	10 m Ω Max.(Initial) 20 m Ω Max(Final)	Mate connectors, measure by dry circuit, 20mV Max., 10mA Max. (EIA-364-23)		
Insulation Resistance	100 MΩ Min.(Initial)	With completely mated connector, use a megaohm meter set to DC 500V to measure between the adjacent terminal and between terminal and housing. (EIA-364-21)		
Dielectric Withstanding Voltage	No discharge,flashover or breakdown. Current leakage: 10µ A max.	1000 V AC Min.at sea level for 1 minute. Test between adjacent contacts of unmated connectors.(EIA-364-20)		
Overcurrent Loading	No ignition is allowed during the test	Mate connectors,measure by dry circuit,14A Max.for 60 minute.Wire size:CAVS0.5mm² <ex>:Terminals energized current</ex>		
Temperature rise	25°C Max. Under loaded specified Current:3A.	Mate connector : measure the temperature rise at rated current until temperature stable. The ambient condition is still air at 25' Wire size:CAVS 0.5 mm² <ex>:Terminals energized current Half energized</ex>		



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MECHANICAL							
Durability		/cles. Ω Max.(Final)	The sample should be mounted in the tester and fully mated and unmated the number of cycles specified at the rate of 100mm/min.(EIA-364-09)				
	Pos.	Mating Force:16.6Kgf Max					
	16	Unmating Force:7Kgf Min	Operation speed :100mm/minute. Measure the force required to mate/Unmate connector. (EIA-364-13)				
Mating / Unmating Forces	Pos.	Mating Force: 20.8Kgf Max	(Please noted that the cable side is from "JEY")				
	20	Unmating Force: 7.8Kgf Min					
Vibration	1µs ľ 20 m	Max Ω Max.(Final)	Vibration Accelation:6.8G Vibration Frequency: 10-50-10 HZ Cycle / 8min Duration :Up and down directions for 4 hours forward and rearward directions for 2 hours. Right and left directions for 2 hours. (EIA-364-28 Condition Ⅰ,Ⅱ)				
Terminal / Housing Retention Force		C direction:5.9kgf Min. D direction:2.0kgf Min.	Apply axial pull out force at the speed rate of 200 mm/minute. On the terminal assembled in the housing.				
Shock (Mechanical) 1 μs Max.			Subject mated connectors to 50 G's (peak value) half-sine shock pulses of 11 milliseconds duration. Three shocks in each direction shall be applied along the three mutually perpendicular axes of the test specimen (18 shocks). The electrical load condition shall be 100mA maximum for all contacts. (EIA-364-27, test condition A)				



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ENVIRONMENTAL						
Item	Requirement	Standard				
Thermal Shock	See Product Qualification and Test Sequence Group 5	Mate module and subject to follow condition for 100 cycles 1 cycles: -40+0/5-5°C,30 minutes +105+3/-0°C,30 minutes (EIA-364-32,test condition VIII)				
Solder ability	Solder able area shall have minumum of 95%solder coverage	And then into solder bath, Temperature at 245+5°C,for4-5sec (EIA-364-52)				
Humidity	See Product Qualification and Test Sequence Group 5	Mated Connector 85°C,85%HR,1000hours (EIA-364-31)				
Temperature life(cold)	See Product Qualification and Test Sequence Group 8	Subject mated connectors to temperature life at -40°C for 96 hours.Measure Signal (EIA-364-59)				
Temperature life(Heat)	See Product Qualification and Test Sequence Group 9	Subject mated connectors to temperature life at 120°C for 96 hours.Measure Signal (EIA-364-17,Test condition A)				
Resistance to Wave Soldering Heat	See Product Qualification and Test Sequence Group 7 (Lead Free)	Solder Temp : 265±5℃ , 10±0.5 sec.				



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6 PRODUCT QUALIFICATION AND TEST SEQUENCE

[-														
				Т	est Grou	ıp								
Test or Examination	1	2	3	4	5	6	7	8	9					
	Test Sequence													
Examination of Product					1 . 7		1	1 ` 6	1、6					
Low Level Contact Resistance			1 \ 5	1 \ 4	2、10		3	2 \ 9	2、9					
Insulation Resistance					3 \ 9			3、8	3 · 8					
Dielectric Withstanding Voltage					4 \ 8			4 \ 7	4 · 7					
Overcurrent Loading	1													
Temperature rise		1												
Mating / Unmating Forces			2 \ 4											
Durability Vibration			3											
				2										
Terminal/housing Retention Force						1								
Shock (Mechanical)				3										
Resistance to Wave Soldering Heat							2							
Thermal Shock					5									
Humidity					6									
Solderability						2								
Temperature life(cold)								5						
Temperature life(Heat)									5					
Sample Size	2	2	4	4	4	4	4	4	4					